

1           1. (Currently amended) A low cost machine vision apparatus for reducing the cost of  
2 conventional machine vision products, their inspection and quality control processes by  
3 eliminating the need for personal computers and frame grabbers, said apparatus comprising:

4           a) a lens for directing reflected light from ~~a standard section of an objects~~ upon a sensor  
5 array to obtain electronic data in spatial segments representative of said objects ~~standard section~~;

6           b) a low cost controller for obtaining the electronic data representative of said reflected  
7 light ~~of said standard section of said array~~ from a selected object and for obtaining data  
8 representative of additional reflections of light in spatial segments from ~~an~~ additional objects;

9           c) said controller including a digital logic chip for comparing the data obtained from said  
10 selected object ~~standard section~~ with the data representative of additional reflections in accord  
11 with an algorithm and for generating a signal indicative of the results of said comparison.

1           2. An apparatus as recited in claim 1 in which said apparatus includes an A-D converter  
2 for converting the data to digital form and for facilitating said comparison.

1           3. (Cancelled) ~~An apparatus as recited in claim 1 in which said additional reflections are~~  
2 ~~taken from a different object for comparing the two objects.~~

1           4. An apparatus as recited in claim 1 in which said controller comprises a  
2 microcontroller having a first memory for receiving reflected light from said selected object ~~a~~  
3 ~~standard section~~ and a second memory for receiving data representative of the additional  
4 reflections.

1           5. (Currently amended) An apparatus as recited in claim 1 in which said ~~microcontroller~~  
2 controller is a digital signal processor.

1           6. An apparatus as recited in claim 5 in which said controller is programmed to  
2 repeatedly obtain additional reflections and to make said comparisons in real time and at high  
3 speed.

1           ~~6. 7.~~ (Currently amended) A low cost, optical inspection apparatus for optical surface  
2 inspection of an object ~~without the use of a frame grabber and PC~~, said apparatus comprising:

3           a) a lens unit for directing reflected light from an acceptable, standard surface of an  
4 object upon a sensor array;

5           b) a low cost comparator connected to said sensor array and having a first memory for  
6 receiving and storing signals representative of the magnitude of the light reflected from the  
7 acceptable, standard surface of the object;

8           c) said comparator having associated additional memory for receiving from said array  
9 signals reflecting the ~~reflecting the~~ magnitude of the light reflected from additional surfaces of  
10 the object;

11           d) said comparator also having a logic unit and a control algorithm for comparing the  
12 similarity of the signals of the standard with the signals of the light reflected from additional  
13 surfaces of an object and for indicating the results of said comparison.

1           ~~7. 8.~~ (Currently amended) An optical inspection apparatus as recited in claim ~~6 7~~ in  
2 which the signals representative of the standard are taken from along a first line on the leading  
3 edge of said object.

1           ~~8. 9.~~ (Currently amended) An optical inspection apparatus as recited in claim ~~6 7~~ in  
2 said sequential signals are taken from segments on the surface of different objects.

1           ~~9. 10.~~ (Currently amended) An optical inspection apparatus as recited in Claim ~~6 7~~ in

2 which said the results includes identification of a deviation from the acceptable standard surface.

1 ~~10~~. 11. (Currently amended) An optical inspection apparatus as recited in Claim ~~6~~ 7 in  
2 which said apparatus has an analog to digital converter for converting said signals to digital  
3 information.

1 ~~11~~. 12. (Currently amended) An apparatus as recited in Claim ~~6~~ 7 in which said  
2 controller is a Digital Signal Processor.

1 ~~12~~. 13. (Currently amended) A low cost, real time, digital diagnostic inspection unit for  
2 examining an object, said apparatus comprising:

3 a) a digital identifier having an associated first memory containing a "standard"  
4 electronic information representative of the reflected light from spatial segments of an object and  
5 a second associated memory containing electronic information representative of reflected light  
6 from spatial segments of an object to be inspected;

7 b) said identifier having a logic unit for comparing the electronic information of the  
8 object to be inspected with the standard electronic information and for providing an output  
9 signal indicative of similarity of the standard with the object.

1 ~~13~~. 14. (Currently amended) An apparatus as recited in claim ~~12~~ 13 in which said  
2 standard electronic information is taken from a manufactured part.

1 ~~14~~ 15. (Currently amended) An apparatus as recited in claim ~~12~~ 13 in which said  
2 digital identifier comprises a digital signal processor.

1 ~~15~~. 16. (Currently amended) An apparatus as recited in claim ~~12~~ 13 in includes a means

for including spectral electronic information of the reflected light.

~~16~~. 17. (Currently amended) A low cost, optical method for inspecting an object, said method comprising the steps of

- a) obtaining digital data representing a spatial distribution of reflected light taken directly from an object and placing same in electronic memory as a standard of comparison;
- b) obtaining digital data representing a spatial distribution of reflected light from another ~~surface of an object to be inspected~~ and placing same in electronic memory;
- c) comparing said digital data of said spatial distribution of the standard of comparison with the digital data of reflected light from said other object ~~surface~~ through a regression algorithm to determine the similarity of reflected light from the segments.

~~17~~. 18. (Currently amended) A method as recited in claim ~~16~~ 17 in which the spatial distribution includes a color distribution.

~~18~~. 19. (Currently amended) A method as recited in claim ~~16~~ 17 in which the spatial distribution comparison includes a full spectrum color comparison.

~~19~~. 20. (Currently amended) A method as recited in claim ~~16~~ 17 in which said comparison is performed by an algorithm in a digital comparator.

~~20~~. 21. (Currently amended) A low cost, high speed method for surface inspection of plastic, metal, woven and non-woven materials, said method comprising the steps of

- a) obtaining digital data representing a spatial distribution of reflected light from a plurality of segments of a line of a material without flaws and placing same in electronic memory as a standard of comparison;

6 b) obtaining digital data representing a second spatial distribution of reflected light from  
7 a plurality of segments along an additional line of said material;

8 c) comparing said spatial distributions of reflected light to determine the similarity of the  
9 standard of comparison with the additional line.

1 ~~21~~. 22. (Currently amended) A method as recited in claim ~~20~~ 21 in which a plurality of  
2 spatial distributions of reflected light are taken along surface increments of the materials and are  
3 compared at high speeds to determining the conformity of the surface of the material with the  
4 standard.

1 ~~22~~. 23. (Currently amended) A method as recited in claim ~~20~~ 21 in which spatial  
2 distribution includes information pertaining to the color of the material.

1 ~~23~~. 24. (Currently amended) A low cost vision apparatus for detecting a change in  
2 conditions, said apparatus comprising:

3 a) a lens for focusing a spatial distribution of ~~reflected~~ light from a target section  
4 representing ~~desired~~ specific conditions upon a sensor array;

5 b) a sensor array for receiving said distribution and for generating electronic data  
6 representative of said distribution;

7 c) a comparator for obtaining the electronic data representing the ~~desired~~ specific  
8 conditions and for obtaining electronic data from a sensor array representing subsequent  
9 conditions;

10 d) said comparator containing a logic unit and an algorithm for comparing the ~~desired~~  
11 specific conditions with the subsequent conditions and for providing a signal indicating the  
12 results of the comparison.

13       ~~24.~~ 25. (Currently amended) A vision apparatus as recited in claim ~~23~~ 24 in which said  
14 vision apparatus is mounted as a safety device adjacent a machine press and the specific ~~normal~~  
15 condition is one in which a person's appendages are not within an unsafe position on the press.

1       ~~25.~~ 26. (Currently amended) A vision apparatus as recited in claim ~~23~~ 24 in which said  
2 vision apparatus is mounted as a security device adjacent an area to be monitored against  
3 unauthorized entry and the specific ~~normal~~ condition is one in which a person is not within the  
4 ~~desired~~ specific conditions.

1       27. (Added) An apparatus as recited in claim 24 in which said sensor array receiving said  
2 distribution from said target section is the same as the sensor array representing subsequent  
3 conditions.

1       28. (Added) An apparatus as recited in claim 24 in which said apparatus has a switch for  
2 generating electronic data representative of said distribution of said specific conditions.

1       29. (Added) An apparatus as recited in claim 28 said comparator repeatedly compares  
2 said specific conditions with said subsequent conditions.

1       30. (Added) A low cost vision scanning method for the inspection, identification and/or  
2 diagnostic evaluation of an objects, tissue, and/or material, said scanning method comprising:

3       a) obtaining digital data reflecting a first spatial distribution of light from an object, tissue,  
4 and/or material;

5       b) repeatedly obtaining digital data reflecting additional spatial distributions of light from  
6 other objects, tissue, and/or materials;

7 c) electronically comparing said first spatial distribution of light with said additional  
8 spatial distributions of light to determine the similarity and/or difference between them; and  
9 d) emitting a signal reflecting the similarity and/or difference.